

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	115	(250/484.5).CCLS.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/24 19:21
L2	19	laser and puls\$3 and dose adj rate.clm.	US-PGPU B; USPAT	OR	OFF	2005/10/24 19:22
L3	1	(laser and puls\$3 and dose adj rate).clm.	US-PGPU B; USPAT	OR	OFF	2005/10/24 19:22
S1	916	(semiconductor) same test\$4 same radiat\$4	US-PGPU B; USPAT	OR	OFF	2005/10/24 19:15
S2	3111	(324/765).CCLS.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/22 20:52
S3	0	S2 and laser and (dose near3 rate)	US-PGPU B; USPAT	OR	OFF	2005/10/22 20:53
S4	0	does near2 rate	US-PGPU B; USPAT	OR	OFF	2005/10/22 20:53
S5	7062	dose near2 rate	US-PGPU B; USPAT	OR	OFF	2005/10/22 20:54
S6	2	S5 and S2	US-PGPU B; USPAT	OR	OFF	2005/10/22 20:54
S7	16	S2 and laser same (pulse near3 width)	US-PGPU B; USPAT	OR	OFF	2005/10/22 21:35
S8	1	("6914447").PN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/22 21:12
S9	0	("6914447").URPN.	USPAT	OR	OFF	2005/10/22 21:13

S10	16	("20030030444" "20040187050" "3723873" "4535426" "4553225" "4698587" "5395783" "5523597" "6211692" "6239479" "6348356" "6365042" "6410414" "6436737" "6483134" "6484289").PN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/22 21:13
S11	76	S2 and laser same (radia\$4)	US-PGPU B; USPAT	OR	OFF	2005/10/22 21:36
S12	76	S2 and laser same (radia\$4)	US-PGPU B; USPAT	OR	OFF	2005/10/22 21:54
S13	226	ionizing adj radiation adj exposure	US-PGPU B; USPAT	OR	OFF	2005/10/22 21:41
S14	5062	dut	US-PGPU B; USPAT	OR	OFF	2005/10/22 21:54
S15	7	"810420"	US-PGPU B; USPAT	OR	OFF	2005/10/22 22:06
S16	18	(dose near3 rate) same (imag\$4 same test\$4)	US-PGPU B; USPAT	OR	OFF	2005/10/22 22:07
S17	10	("4775640" "5101453" "5177351" "5477158" "5631571" "6057918" "6058497" "6119255" "6300785" "6331782").PN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/22 22:19
S18	3	("4273421" "4854710" "5966019").PN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/23 14:41
S19	3111	(324/765).CCLS.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/23 14:43

S20	76	S19 and laser same (radia\$4)	US-PGPU B; USPAT	OR	OFF	2005/10/23 14:43
S21	0	S20 and wafter	US-PGPU B; USPAT	OR	OFF	2005/10/23 14:43
S22	41	S20 and wafer	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:09
S23	0	laser adj dose near2 rate	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:10
S24	7	laser near2 dose near2 rate	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:11
S25	0	laser same dose near2 rate and (semiconductor\$1 semi\$1conductor\$1) same test\$3	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:12
S26	9	laser same dose same rate and (semiconductor\$1 semi\$1conductor\$1) same test\$3	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:15
S27	9	laser same dose same rate and (semiconductor\$1 semi\$1conductor\$1) same (test\$3 evaluat\$4)	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:15
S28	15	laser same dose same rate and (semiconductor\$1 semi\$1conductor\$1) same (test\$3 evaluat\$4 inspect\$4)	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:15
S29	46531	S28 nt S26	US-PGPU B; USPAT	OR	OFF	2005/10/23 17:42
S30	6	S28 not S26	US-PGPU B; USPAT	OR	OFF	2005/10/23 15:15

S31	8051	(test\$3 evaluat\$3 inspect\$3) same (wafer semi\$1conductor\$1) and (imag\$4 and radiat\$4)	US-PGPU B; USPAT	OR	OFF	2005/10/23 17:43
S32	298	S31 and "324"/\$.ccls.	US-PGPU B; USPAT	OR	OFF	2005/10/23 17:47
S33	2	((("6803777") or ("6512385")).PN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/24 10:44
S34	20	single adj event adj transient	US-PGPU B; USPAT	OR	OFF	2005/10/24 11:22
S35	0	laser\$1 same does\$1 near3 rate\$1	US-PGPU B; USPAT	OR	OFF	2005/10/24 11:22
S36	183	laser\$1 same dose\$1 near3 rate\$1	US-PGPU B; USPAT	OR	OFF	2005/10/24 12:58
S37	2	((("5406072") or ("5962857")).PN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/24 14:45
S38	1	("4510565").PN.	US-PGPU B; USPAT; USOCR	OR	OFF	2005/10/24 14:45